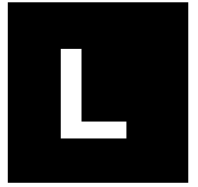


Line-level Test Module

option for

AIO Test System



The Line-level Test Module (AIO-L) is designed for making basic acoustic or electrical measurements of a device under test (DUT). AIO-L is a configuration option for the AIO Test System and requires the AIO chassis to operate.



HARDWARE FEATURES:

- Four mic/line inputs
- CCP/IEPE/ICP microphone power
- TEDS reader for microphone data
- Two balanced line-level outputs

KEY APPLICATIONS:

- Mobile devices
- Communications systems

MIC/LINE INPUTS:

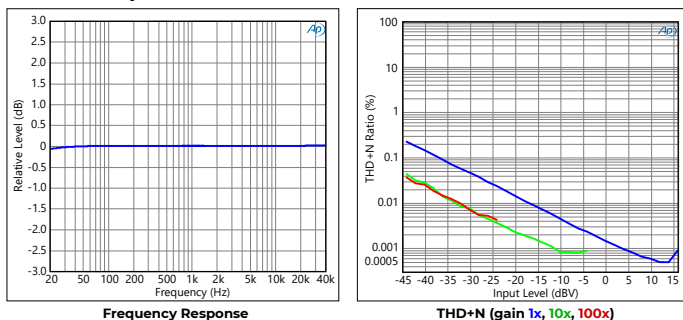
Four low-noise inputs accommodate a very wide range of input voltages, from dynamic microphones to line-level inputs. Features include adjustable gain, constant current power, and TEDS readers.

LINE-LEVEL OUTPUTS:

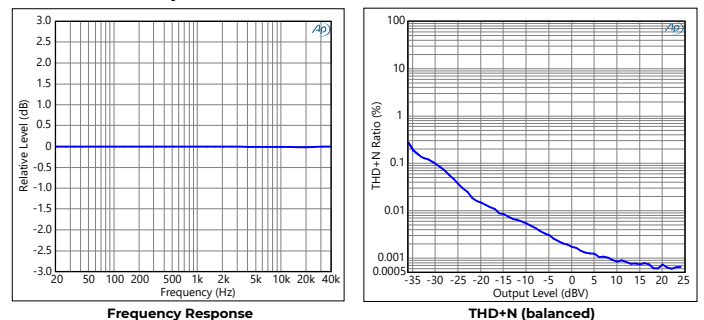
Two high-quality low-noise, low-distortion balanced line-level outputs.

PERFORMANCE GRAPHS:

Mic/Line Inputs



Line-level Outputs



The Echo AIO™ is a modular audio test platform ideally suited for high-volume production-line testing and QA/QC verification. The AIO combines the functionality of multiple standalone devices into a single, integrated unit, making test stations both more reliable and less expensive.

LINE-LEVEL MODULE COMMON CONFIGURATIONS: (Other configurations may be available—check with your dealer.)

| Model | Inner Module | Outer Module | Mic/Line Inputs | Line Outputs | Headphone Outputs | Amp Outputs | Impedance | Digital | 5VDC & Battery Simulator | GPIO | PTH |
|--------|--------------|--------------|-----------------|--------------|-------------------|-------------|-----------|-----------|--------------------------|------|-----|
| AIO-L1 | AIO-L | | 4 | 2 | | | | | | | |
| AIO-L2 | AIO-L | AIO-L | 8 | 4 | | | | | | | |
| AIO-LT | AIO-L | AIO-T | 4 | 2 | | | | TDM 10/10 | | | |
| AIO-SL | AIO-S | AIO-L | 6 | 2 | | 2 | 1 | | | | |

SPECIFICATIONS:

| Microphone / Line Inputs | |
|------------------------------------|-----------------------------------------------------------------------------------------------------------------------------|
| Input impedance: | 1 M Ω |
| Input coupling: | AC |
| Input gain: | 1x, 10x, and 100x |
| Voltage, full scale (1x gain): | 8.75 Vpk (+15.8 dBV) |
| Voltage, maximum: | ± 15 Vpk |
| Frequency response: | ± 0.01 dB (10 Hz – 22 kHz) (48k SR) ± 0.01 dB (10 Hz – 44 kHz) (96k SR) ± 1 dB (10 Hz – 86 kHz) (192k SR) |
| Input bandwidth (-3 dB @ 192k SR): | 94 kHz |
| Dynamic range (20 kHz BW): | 112 dB |
| THD+N (1x gain, 20 kHz BW): | < -105 dB (20 Hz – 20 kHz) |
| Noise, residual: | 17 μ V |
| IMD (SMPTE 4:1 @ full scale): | -95 dB |
| Crosstalk: | < -122 dB (20 Hz – 20 kHz) |
| Phase error: | < $\pm 0.1^\circ$ @ 20 kHz |
| Constant current supply: | CCP/IEPE/ICP, 4 mA |
| TEDS reader: | IEEE 1451.4 Class 1 |

| Line Outputs | |
|-------------------|--------------|
| Output impedance: | 102 Ω |

| | |
|-------------------------------------|-----------------------------------------------------------------------------------------------------------------------------|
| Output coupling: | DC |
| Minimum load: | 600 Ω |
| Voltage, maximum: | 16 Vrms (+24 dBV) (bal) 8 Vrms (+18 dBV) (unbal) |
| DC offset, range: | ± 22.6 VDC (bal); ± 11.3 VDC (unbal) |
| DC offset, residual: | < ± 1.6 mV |
| Frequency response: | ± 0.01 dB (10 Hz – 21 kHz) (48k SR) ± 0.01 dB (10 Hz – 43 kHz) (96k SR) ± 1 dB (10 Hz – 75 kHz) (192k SR) |
| Output bandwidth (-3 dB @ 192k SR): | 90 kHz |
| Dynamic range (20 kHz BW): | 120 dB |
| THD+N (20 kHz BW): | < -102 dB (20 Hz – 20 kHz) |
| Noise, residual: | 17 μ V (bal), 8.5 μ V (unbal) |
| IMD (SMPTE 4:1 @ full scale): | -101 dB |
| Crosstalk: | < -122 dB (20 Hz – 20 kHz) |
| Phase error: | < $\pm 0.1^\circ$ @ 20 kHz |

| General | |
|-------------|----------------------------------------------------|
| Power: | 90 – 264 VAC, 50/60 Hz, 60 W |
| Dimensions: | 17.5" (44.4 cm) x 8.75" (22.2 cm) x 1.75" (4.4 cm) |
| Weight: | 42.5 lbs (19.3 kg) |

AIO Test System (See system datasheet for more details)



Shown: AIO-LC rear view with **L** line-level and **C** combo test modules.

FEATURES:

- High accuracy
- Cost effective
- Silent—no fan!
- Standard USB 2.0 audio class interface
- Wide test & measurement software compatibility
- Runs on Windows (10 or later) or macOS
- ASIO, WASAPI, & Core Audio protocols



CONTROL PANEL SOFTWARE:

Provides comprehensive level monitoring and control over hardware settings, including transducer power, TEDS data, gain, TDM format, and calibration. Command-line and API access to settings is also available.

TEST & MEASUREMENT SOFTWARE:

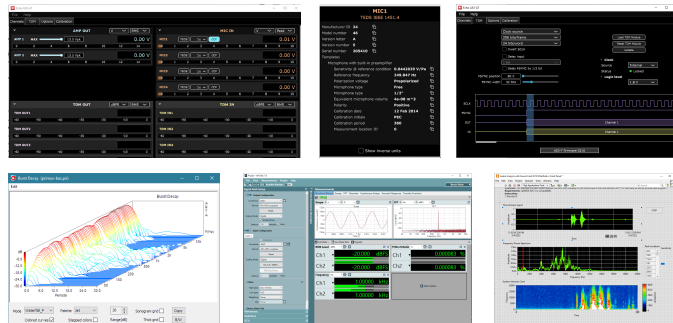
Choose from a wide variety of third-party test and measurement software, including APx500 Flex, ARTA, LabVIEW, and MATLAB. The AIO system works just like a standard sound card for Windows, Mac, or Linux.

Echo Test + Measurement

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MODULE OPTIONS: (See individual datasheets for details and configurations)

- A Acoustic:** Four mic/line inputs with CCP, TEDS; two 10 W class-D amplifier outputs.
- C Combo:** GPIO; 5 VDC fixed supply; 5 VDC battery simulator; Pressure, temperature, and humidity sensor.
- H Headphone:** Four mic/line inputs with CCP, TEDS; two headphone/earbud outputs with impedance measurement.
- L Line Level:** Four mic/line inputs with CCP, TEDS; two balanced line-level outputs.
- S Speaker:** Two mic/line inputs with CCP, TEDS; two 10 W class-D amplifier outputs; built-in speaker impedance measurement.
- T TDM:** Digital TDM, up to 10 channels, 24 or 32 bit samples.



Specifications are subject to change without notice. All trademarks or registered trademarks are the property of their respective owners. The AIO Test System is CE compliant.

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